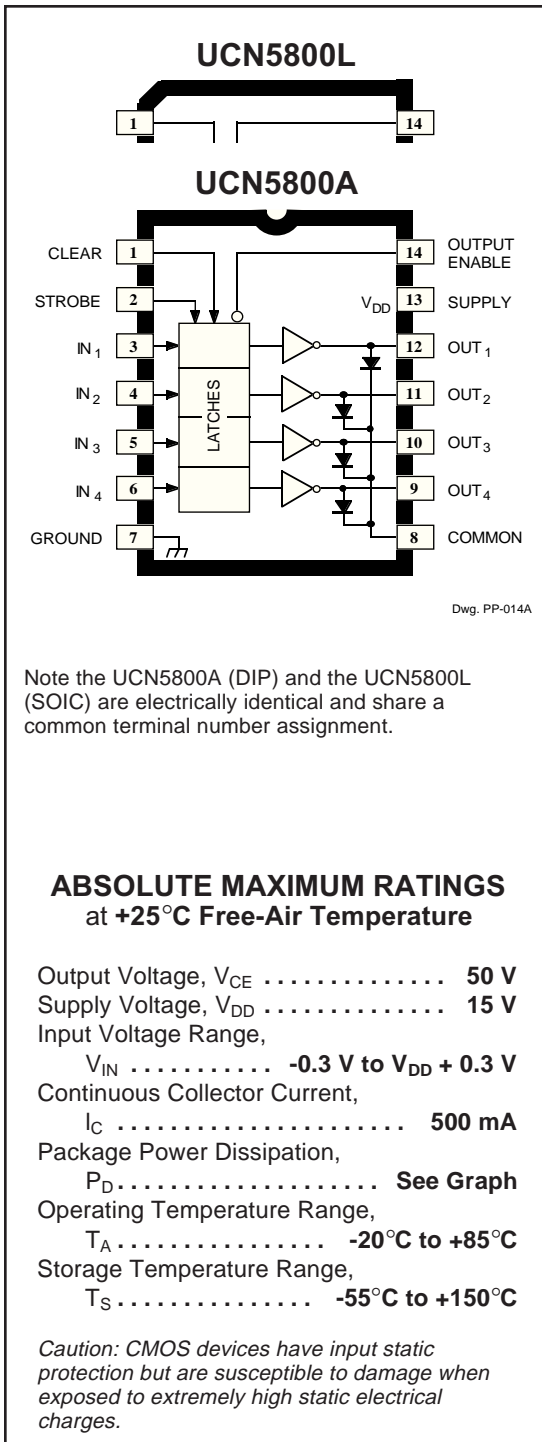


5800 AND 5801

BiMOS II LATCHED DRIVERS



The UCN5800A/L and UCN5801A/EP/LW latched-input BiMOS ICs merge high-current, high-voltage outputs with CMOS logic. The CMOS input section consists of 4 or 8 data ('D' type) latches with associated common CLEAR, STROBE, and OUTPUT ENABLE circuitry. The power outputs are bipolar npn Darlington. This merged technology provides versatile, flexible interface. These BiMOS power interface ICs greatly benefit the simplification of computer or microprocessor I/O. The UCN5800A and UCN5800L each contain four latched drivers; the UCN5801A, UCN5801EP, and UCN5801LW contain eight latched drivers.

The UCN5800A/L and UCN5801A/EP/LW supersede the original BiMOS latched-input driver ICs (UCN4400A and UCN4801A). These second-generation devices are capable of much higher data input rates and will typically operate at better than 5 MHz with a 5 V logic supply. Circuit operation at 12 V affords substantial improvement over the 5 MHz figure.

The CMOS inputs are compatible with standard CMOS and NMOS circuits. TTL circuits may mandate the addition of input pull-up resistors. The bipolar Darlington outputs are suitable for directly driving many peripheral/power loads: relays, lamps, solenoids, small dc motors, etc.

All devices have open-collector outputs and integral diodes for inductive load transient suppression. The output transistors are capable of sinking 500 mA and will withstand at least 50 V in the OFF state. Because of limitations on package power dissipation, the simultaneous operation of all drivers at maximum rated current can only be accomplished by a reduction in duty cycle. Outputs may be paralleled for higher load current capability.

The UCN5800A is furnished in a standard 14-pin DIP; the UCN5800L and UCN5801LW in surface-mountable SOICs; the UCN5801A in a 22-pin DIP with 0.400" (10.16 mm) row centers; the UCN5801EP in a 28-lead PLCC.

FEATURES

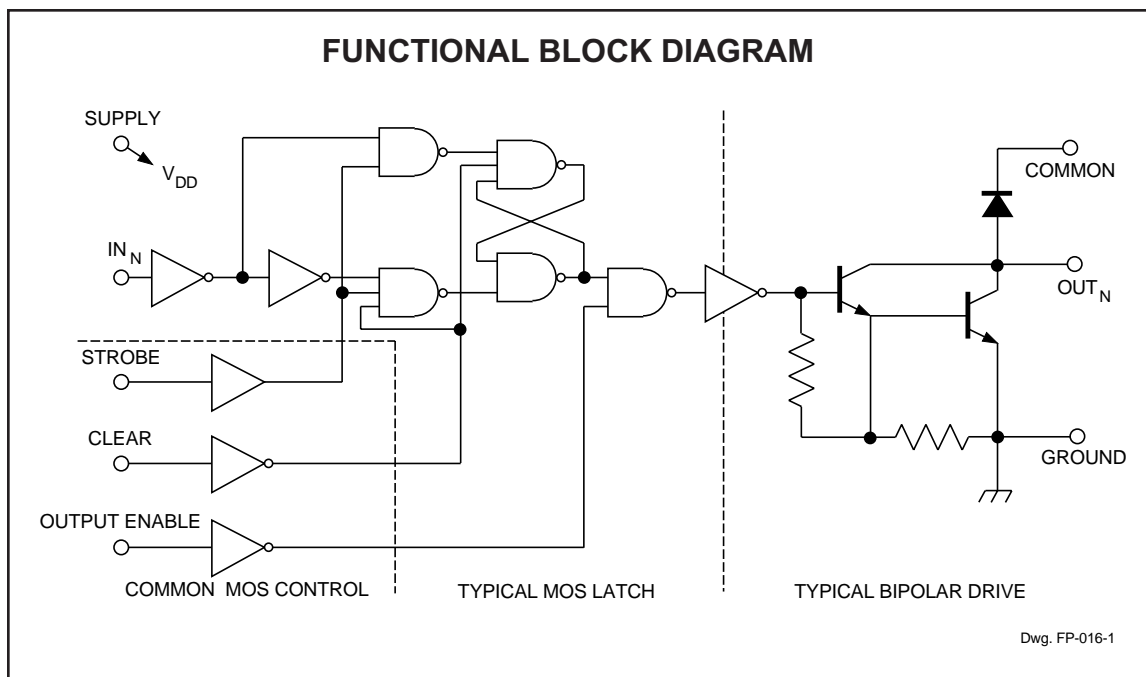
- To 4.4 MHz Data Input Rate
- High-Voltage, High-Current Outputs
- CMOS, NMOS, TTL Compatible Inputs
- Output Transient Protection
- Internal Pull-Down Resistors
- Low-Power CMOS Latches
- Automotive Capable

Always order by complete part number, e.g., **UCN5801EP**.

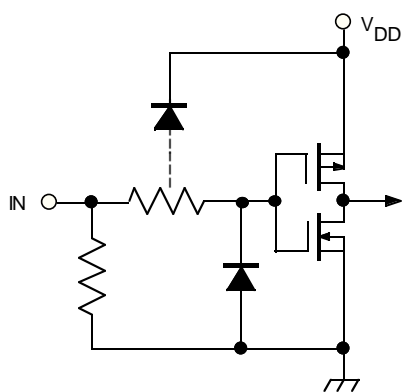
5800 AND 5801

BiMOS II

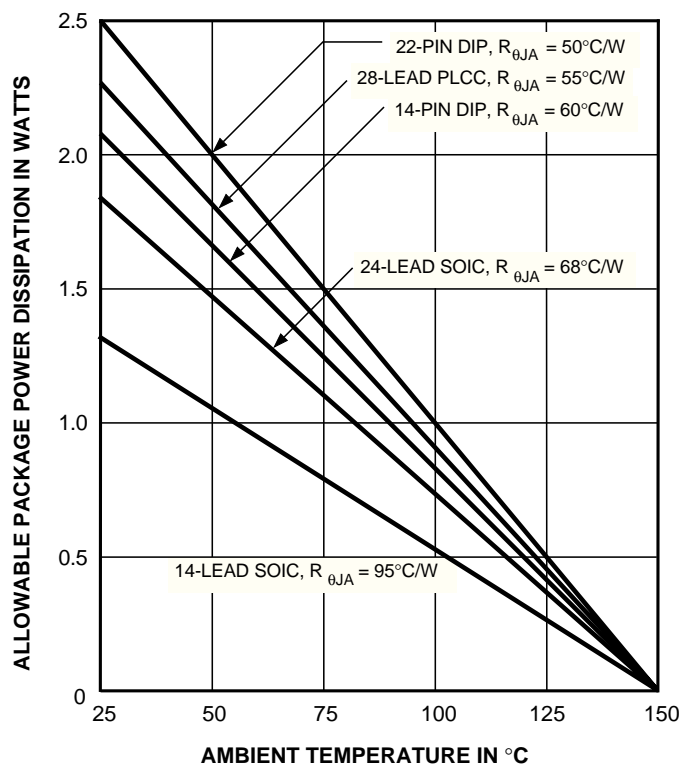
LATCHED DRIVERS



TYPICAL INPUT CIRCUIT



Dwg. EP-010-4A



Dwg. GP-023-1

5800 AND 5801

BiMOS II

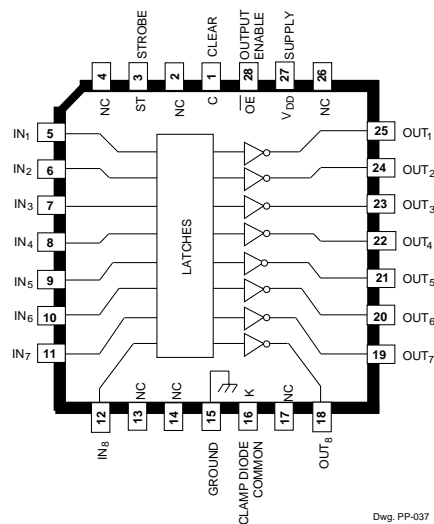
LATCHED DRIVERS

ELECTRICAL CHARACTERISTICS at $T_A = +25^\circ\text{C}$, $V_{DD} = 5\text{ V}$ (unless otherwise noted).

| Characteristic | Symbol | Test Conditions | Limits | | | |
|--------------------------------------|------------------------------|--|--------|------|------|------------------|
| | | | Min. | Typ. | Max. | Units |
| Output Leakage Current | I_{CEX} | $V_{CE} = 50\text{ V}$, $T_A = +25^\circ\text{C}$ | — | — | 50 | μA |
| | | $V_{CE} = 50\text{ V}$, $T_A = +70^\circ\text{C}$ | — | — | 100 | μA |
| Collector-Emitter Saturation Voltage | $V_{CE(SAT)}$ | $I_C = 100\text{ mA}$ | — | 0.9 | 1.1 | V |
| | | $I_C = 200\text{ mA}$ | — | 1.1 | 1.3 | V |
| | | $I_C = 350\text{ mA}$, $V_{DD} = 7.0\text{ V}$ | — | 1.3 | 1.6 | V |
| Input Voltage | $V_{IN(0)}$ | | — | — | 1.0 | V |
| | $V_{IN(1)}$ | $V_{DD} = 12\text{ V}$ | 10.5 | — | — | V |
| | | $V_{DD} = 10\text{ V}$ | 8.5 | — | — | V |
| | | $V_{DD} = 5.0\text{ V}$ (See Note) | 3.5 | — | — | V |
| Input Resistance | r_{IN} | $V_{DD} = 12\text{ V}$ | 50 | 200 | — | $\text{k}\Omega$ |
| | | $V_{DD} = 10\text{ V}$ | 50 | 300 | — | $\text{k}\Omega$ |
| | | $V_{DD} = 5.0\text{ V}$ | 50 | 600 | — | $\text{k}\Omega$ |
| Supply Current | $I_{DD(ON)}$ (Each Stage) | $V_{DD} = 12\text{ V}$, Outputs Open | — | 1.0 | 2.0 | mA |
| | | $V_{DD} = 10\text{ V}$, Outputs Open | — | 0.9 | 1.7 | mA |
| | | $V_{DD} = 5.0\text{ V}$, Outputs Open | — | 0.7 | 1.0 | mA |
| | $I_{DD(OFF)}$ (Total) | $V_{DD} = 12\text{ V}$, Outputs Open, Inputs = 0 V | — | — | 200 | μA |
| | | $V_{DD} = 5.0\text{ V}$, Outputs Open, Inputs = 0 V | — | 50 | 100 | μA |
| Clamp Diode Leakage Current | I_R | $V_R = 50\text{ V}$, $T_A = +25^\circ\text{C}$ | — | — | 50 | μA |
| | | $V_R = 50\text{ V}$, $T_A = +70^\circ\text{C}$ | — | — | 100 | μA |
| Clamp Diode Forward Voltage | V_F | $I_F = 350\text{ mA}$ | — | 1.7 | 2.0 | V |

NOTE: Operation of these devices with standard TTL or DTL may require the use of appropriate pull-up resistors to ensure a minimum logic "1".

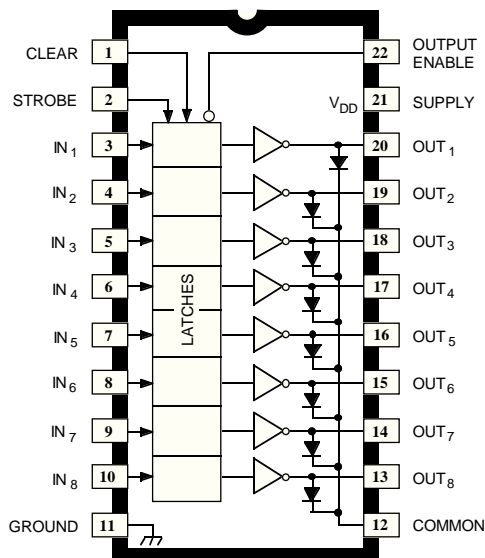
UCN5801EP
(additional pinout diagrams
are on next page)



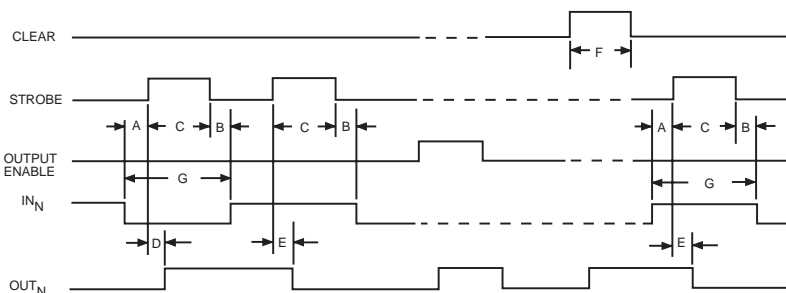
Dwg. PP-037

5800 AND 5801 BiMOS II LATCHED DRIVERS

UCN5801A



Dwg. PP-015



Dwg. No. A-10,895A

TIMING CONDITIONS (Logic Levels are V_{DD} and Ground)

- A. Minimum Data Active Time Before Strobe Enabled
(Data Set-Up Time) **50 ns**
- B. Minimum Data Active Time After Strobe Disabled
(Data Hold Time) **50 ns**
- C. Minimum Strobe Pulse Width **125 ns**
- D. Typical Time Between Strobe Activation and
Output On to Off Transition **500 ns**
- E. Minimum Time Between Strobe Activation and
Output Off to On Transition **500 ns**
- F. Minimum Clear Pulse Width **300 ns**
- G. Minimum Data Pulse Width **225 ns**

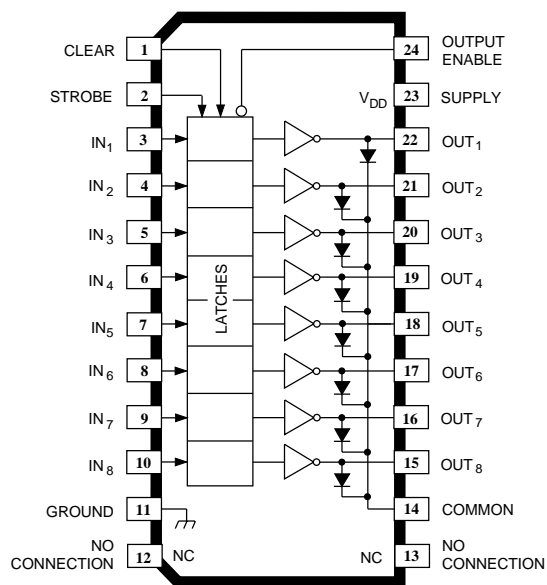
Information present at an input is transferred to its latch when the STROBE is high. A high CLEAR input will set all latches to the output OFF condition regardless of the data or STROBE input levels. A high OUTPUT ENABLE will set all outputs to the OFF condition, regardless of any other input conditions. When the OUTPUT ENABLE is low, the outputs depend on the state of their respective latches.

TRUTH TABLE

| IN_N | STROBE | CLEAR | OUTPUT ENABLE | OUT _N | |
|--------|--------|-------|------------------|------------------|-----|
| | | | | t-1 | t |
| 0 | 1 | 0 | 0 | X | OFF |
| 1 | 1 | 0 | 0 | X | ON |
| X | X | 1 | X | X | OFF |
| X | X | X | 1 | X | OFF |
| X | 0 | 0 | 0 | ON | ON |
| X | 0 | 0 | 0 | OFF | OFF |

X = irrelevant.
t-1 = previous output state.
t = present output state.

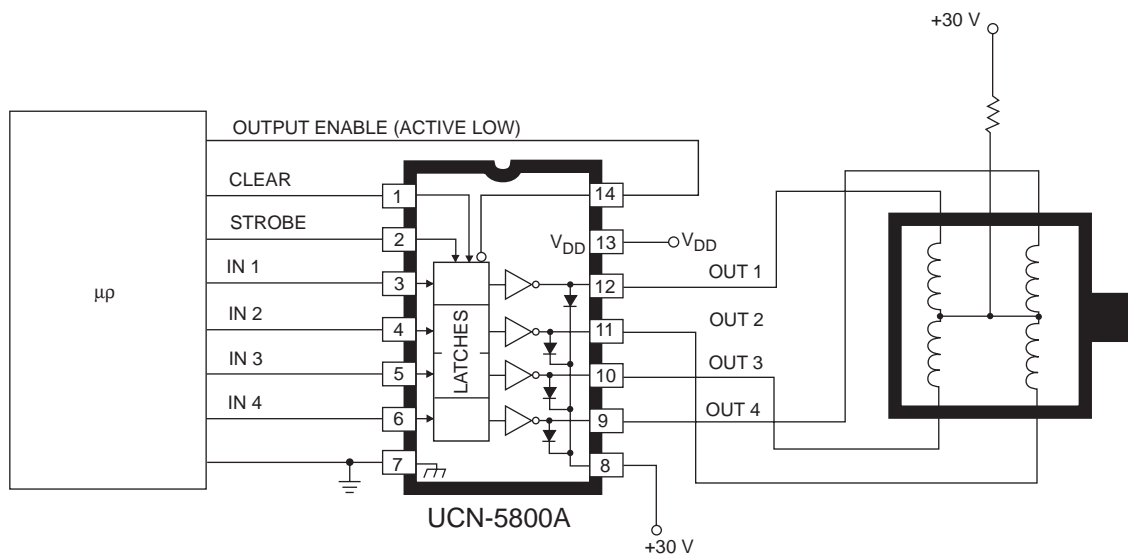
UCN5801LW



Dwg. PP-015-1

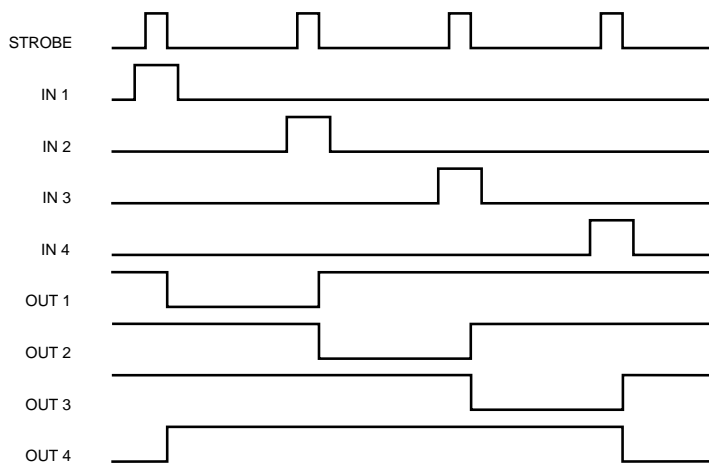
5800 AND 5801 BiMOS II LATCHED DRIVERS

TYPICAL APPLICATION UNIPOLAR STEPPER-MOTOR DRIVE



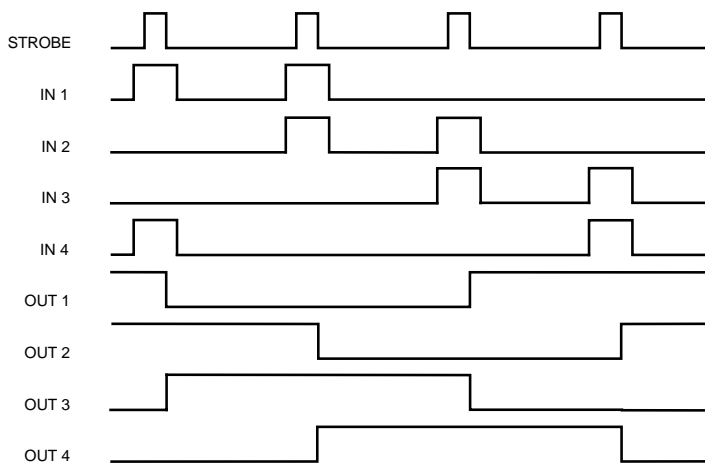
Dwg. No. B-1537

UNIPOLAR WAVE DRIVE



Dwg. GP-060

UNIPOLAR 2-PHASE DRIVE

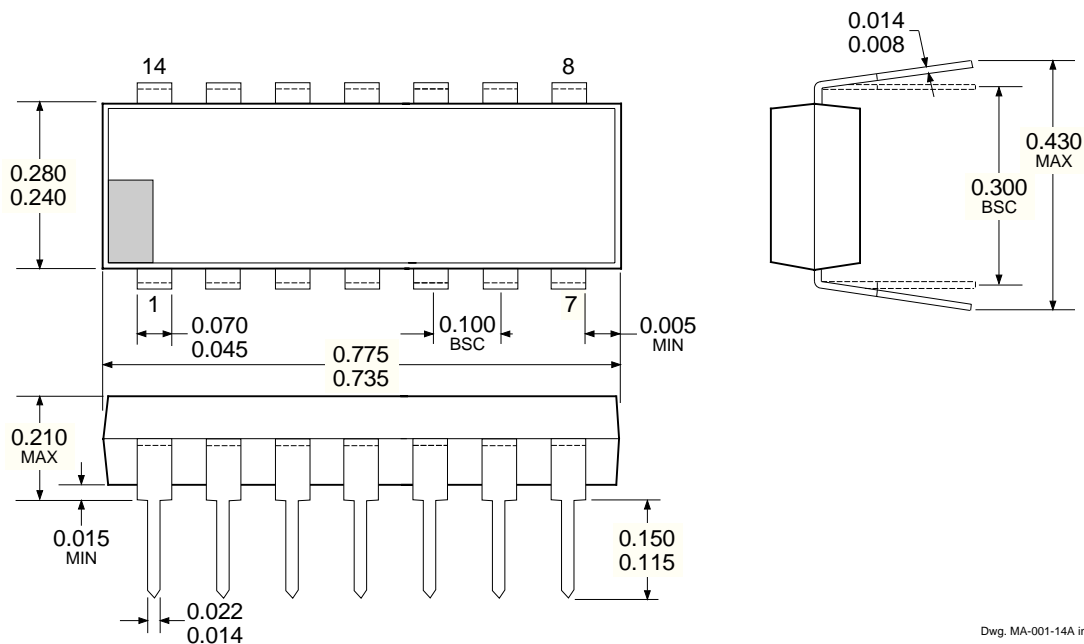


Dwg. GP-060-1

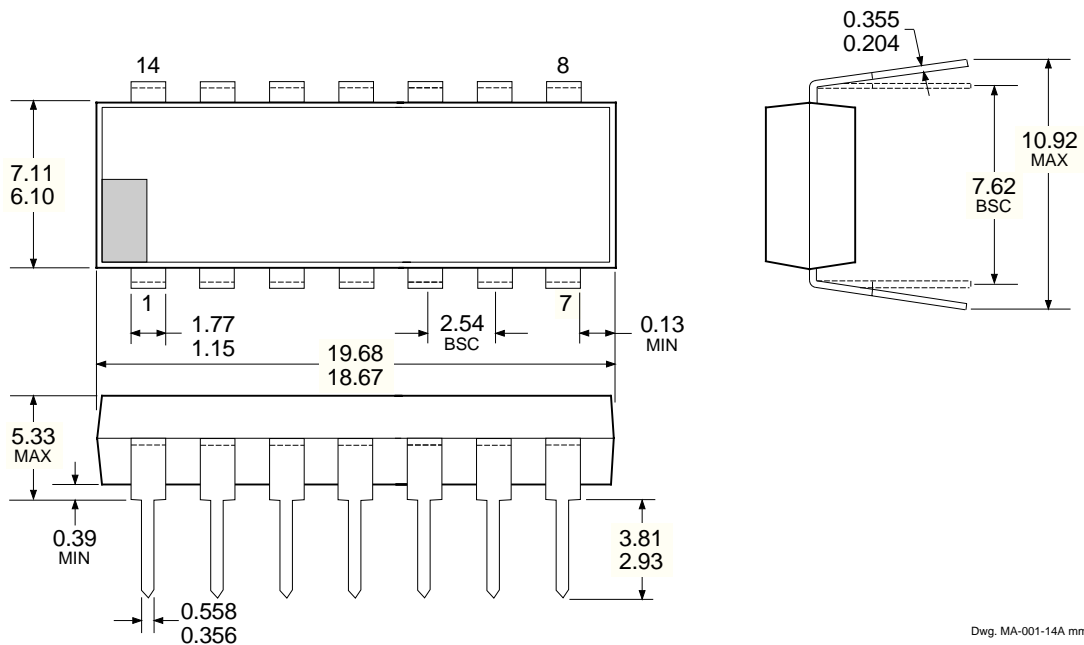
5800 AND 5801 BiMOS II LATCHED DRIVERS

UCN5800A

Dimensions in Inches
(controlling dimensions)



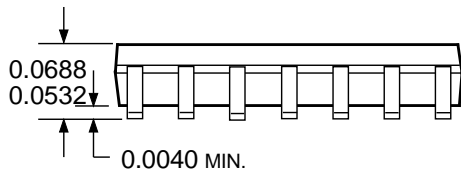
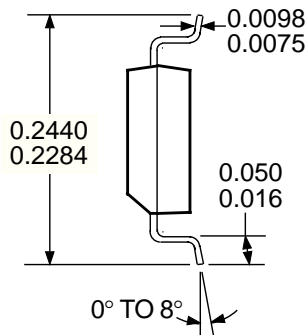
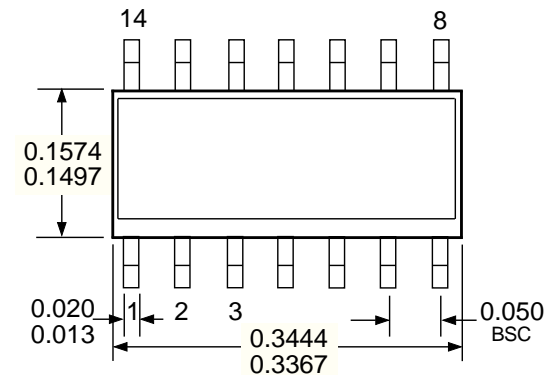
Dimensions in Millimeters
(for reference only)



- NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.
2. Lead spacing tolerance is non-cumulative.
3. Lead thickness is measured at seating plane or below.

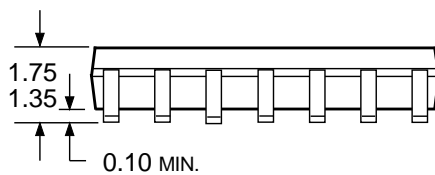
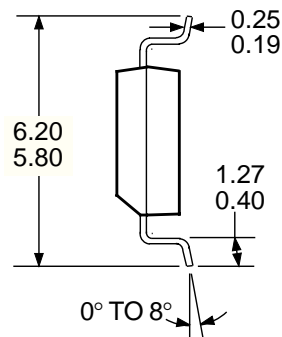
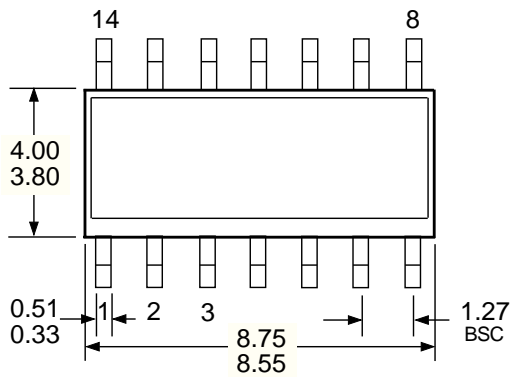
LATCHED DRIVERS

Dimensions in Inches
(for reference only)



Dwg. MA-007-14 in

Dimensions in Millimeters
(controlling dimensions)

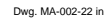


Dwg. MA-007-14A mm

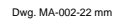
- NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.
2. Lead spacing tolerance is non-cumulative.

LATCHED DRIVERS

Dimensions in Inches
(controlling dimensions)



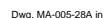
(for reference only)



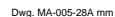
3. Lead thickness is measured at seating plane or below.

LATCHED DRIVERS

Dimensions in Inches
(controlling dimensions)



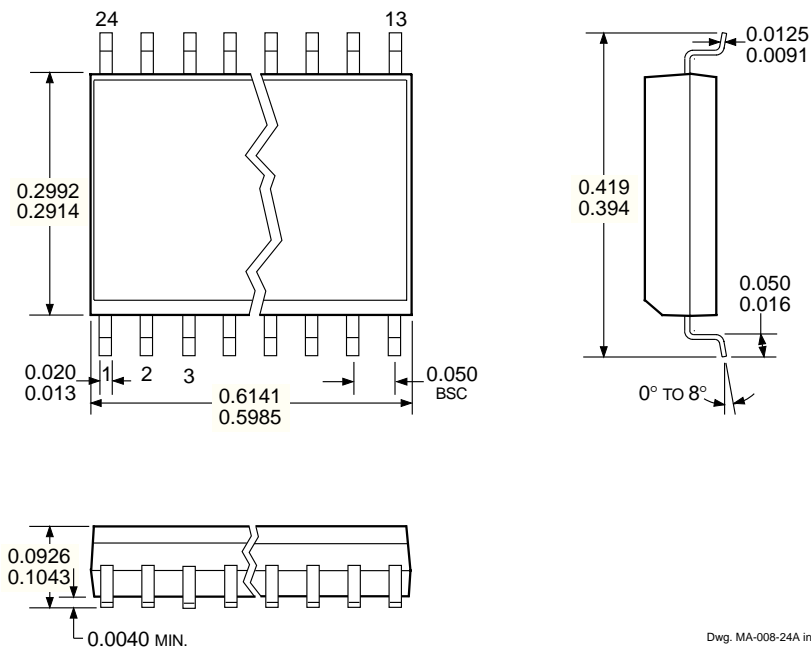
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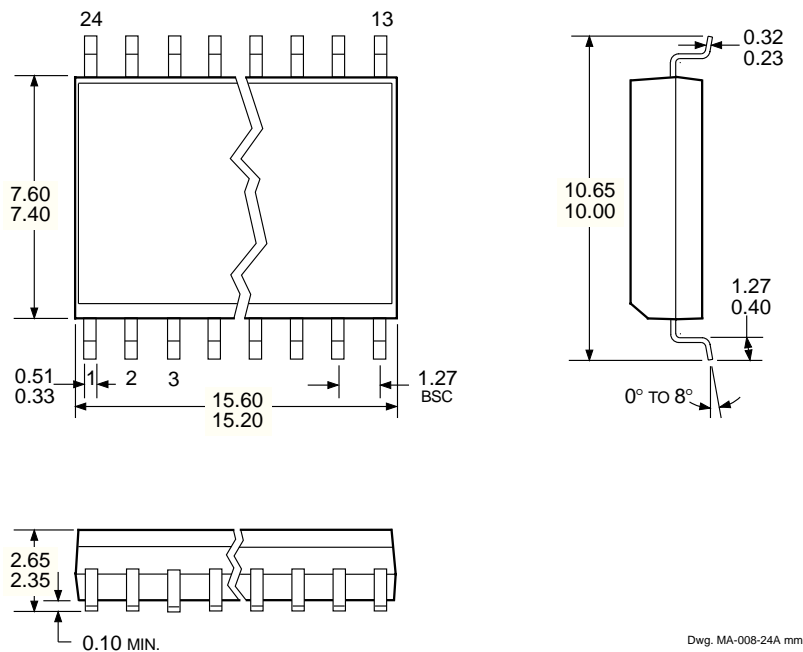
2. Lead spacing tolerance is non-cumulative.

5800 AND 5801 BiMOS II LATCHED DRIVERS

UCN5801LW Dimensions in Inches (for reference only)



Dimensions in Millimeters (controlling dimensions)



- NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.
2. Lead spacing tolerance is non-cumulative.

5800 AND 5801
BiMOS II
LATCHED DRIVERS

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5800 AND 5801
BiMOS II
LATCHED DRIVERS

BiMOS II (Series 5800) & DABiC IV (Series 6800)
INTELLIGENT POWER INTERFACE DRIVERS
SELECTION GUIDE

| Function | Output Ratings * | | Part Number † |
|--|------------------|-------|--------------------|
| SERIAL-INPUT LATCHED DRIVERS | | | |
| 8-Bit (saturated drivers) | -120 mA | 50 V‡ | 5895 |
| 8-Bit | 350 mA | 50 V | 5821 |
| 8-Bit | 350 mA | 80 V | 5822 |
| 8-Bit | 350 mA | 50 V‡ | 5841 |
| 8-Bit | 350 mA | 80 V‡ | 5842 |
| 9-Bit | 1.6 A | 50 V | 5829 |
| 10-Bit (active pull-downs) | -25 mA | 60 V | 5810-F and 6809/10 |
| 12-Bit (active pull-downs) | -25 mA | 60 V | 5811 and 6811 |
| 20-Bit (active pull-downs) | -25 mA | 60 V | 5812-F and 6812 |
| 32-Bit (active pull-downs) | -25 mA | 60 V | 5818-F and 6818 |
| 32-Bit | 100 mA | 30 V | 5833 |
| 32-Bit (saturated drivers) | 100 mA | 40 V | 5832 |
| PARALLEL-INPUT LATCHED DRIVERS | | | |
| 4-Bit | 350 mA | 50 V‡ | 5800 |
| 8-Bit | -25 mA | 60 V | 5815 |
| 8-Bit | 350 mA | 50 V‡ | 5801 |
| SPECIAL-PURPOSE FUNCTIONS | | | |
| Unipolar Stepper Motor Translator/Driver | 1.25 A | 50 V‡ | 5804 |
| Addressable 28-Line Decoder/Driver | 450 mA | 30 V | 6817 |

* Current is maximum specified test condition, voltage is maximum rating. See specification for sustaining voltage limits.
 Negative current is defined as coming out of (sourcing) the output.

† Complete part number includes additional characters to indicate operating temperature range and package style.

‡ Internal transient-suppression diodes included for inductive-load protection.

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115 Northeast Cutoff, Box 15036
 Worcester, Massachusetts 01615-0036 (508) 853-5000